

Search Notes

Application/Control No.

10/821,167

Examiner

B. Clayton McCraw

Applicant(s)/Patent under
Reexamination

JEONG ET AL.

Art Unit

3744

SEARCHED

Class	Subclass	Date	Examiner
None	None		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Primary Examiner, William Tapolcai	4/24/2006	BCM
Consulted with Primary Examiner, William Doerrler	4/27/2006	BCM
Conducted Inventor Name Search	4/27/2006	BCM
EAST Search Notes Attached	4/27/2006	BCM
Consulted with Primary Examiner, Marc Norman	9/18/2006	BCM